

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10576836	KANG ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Eduardo Colon-Santana	2837

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
187	391, 393, 394, 282, 283	2/13/2009	ECS

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST SEARCH plus TEXT SEARCH INCLUDING EPO, JPO AND DERWERT DATABASES	2/13/2009	ECS

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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